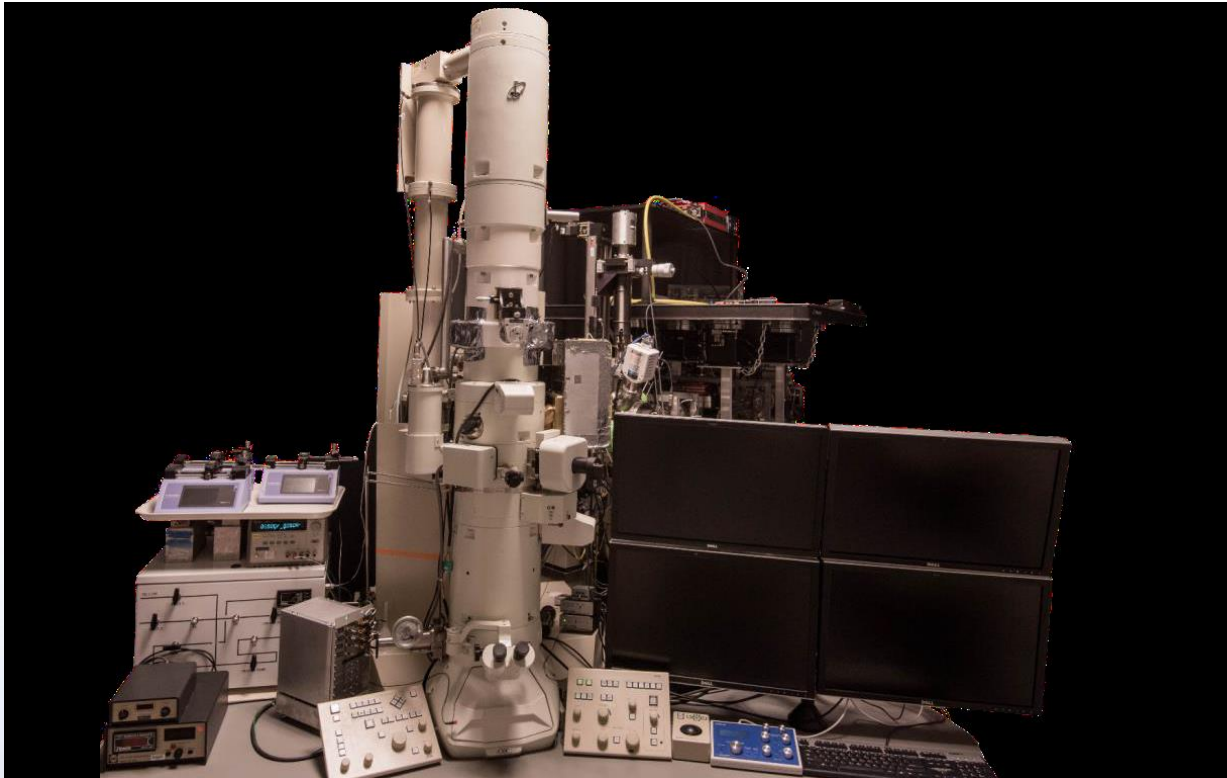


Development of and Initial Results from the First In-Situ Ion Irradiation Dynamic TEM

SAND2017-13107C

S.A. Briggs, P.M. Price, M. Abere, C.M. Barr, S.T. Park, B.W. Reed, D.J. Masiel, D.P. Adams, K. Hattar

December 1, 2017




Collaborators: Sandia: M. Blair, D. Buller, G. Vizkelethy, B.L. Doyle, M.T. Marshall, D. Saiz, J.A. Scott, B.R. Muntifering, W. Wampler, R. Dingreville, S. Foiles
External: T. La Grange A. Lang, M. Taheri, W. Ji, A. Schleife



This work was supported by the US Department of Energy, Office of Basic Energy Sciences. Sandia National Laboratories is a multi-mission laboratory managed and operated by National Technology and Engineering Solutions of Sandia, LLC., a wholly owned subsidiary of Honeywell International, Inc., for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-NA-0003525.

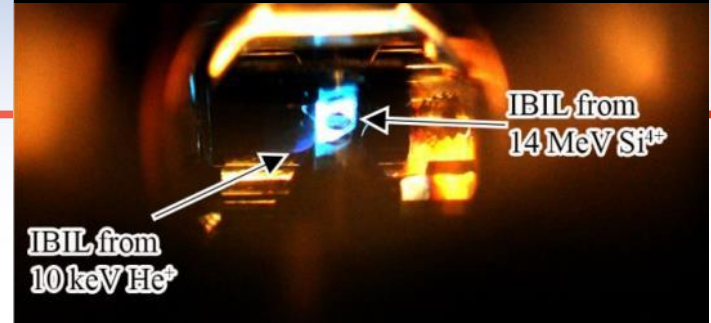
IDES INTEGRATED
DYNAMIC
ELECTRON
SOLUTIONS

 Sandia National Laboratories

Sandia's Concurrent *In situ* Ion Irradiation TEM Facility

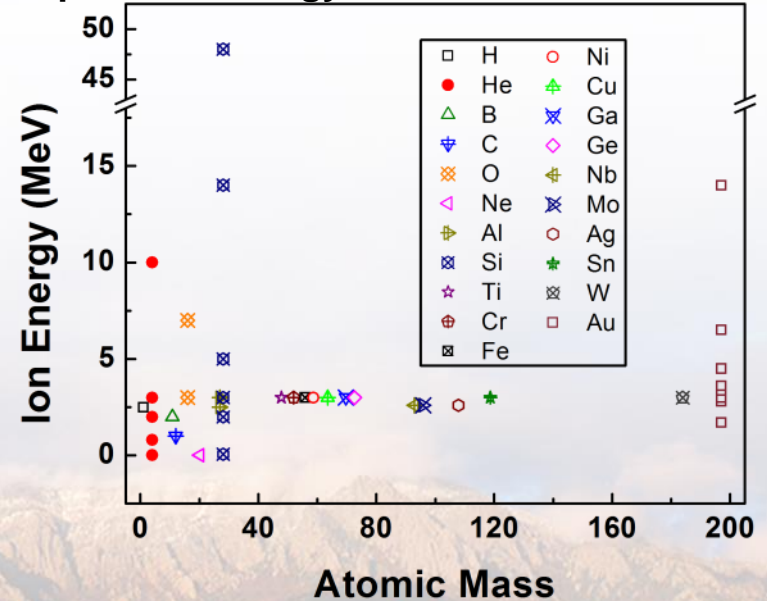
Collaborator: D.L. Buller

Ion beam-induced luminescence (IBIL) from a quartz stage inside the TEM

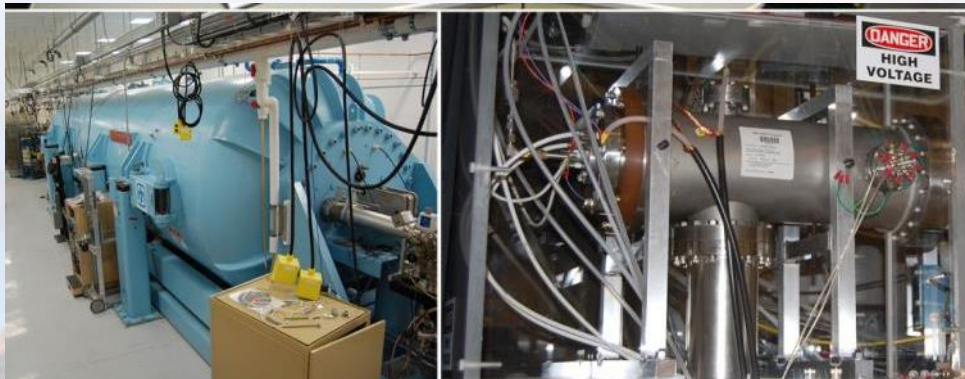
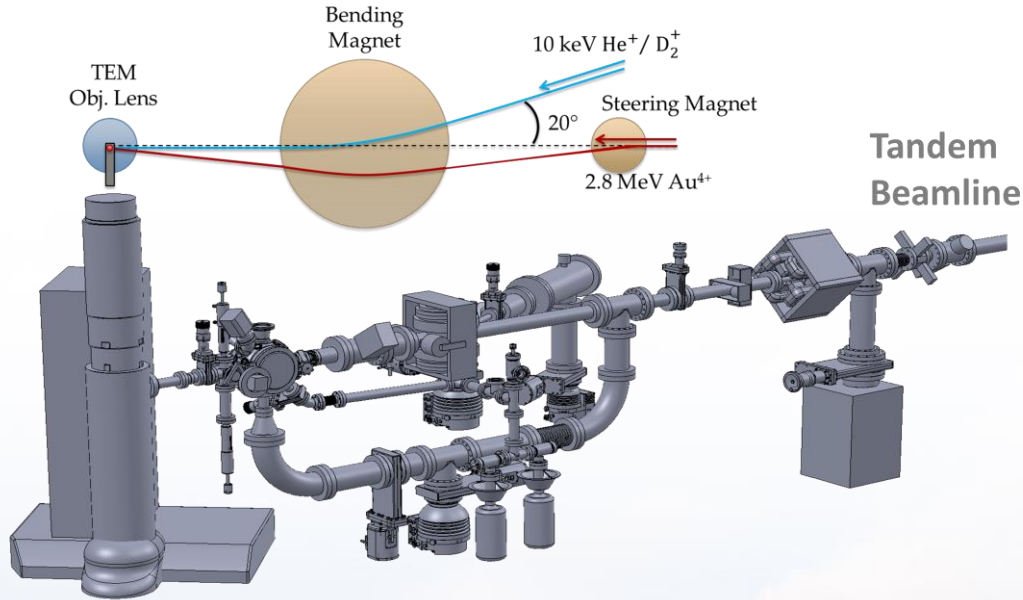


Direct real time observation of ion irradiation, ion implantation, or both with nanometer resolution

Ion species & energy introduced into the TEM



10 kV Colutron - 200 kV TEM - 6 MV Tandem

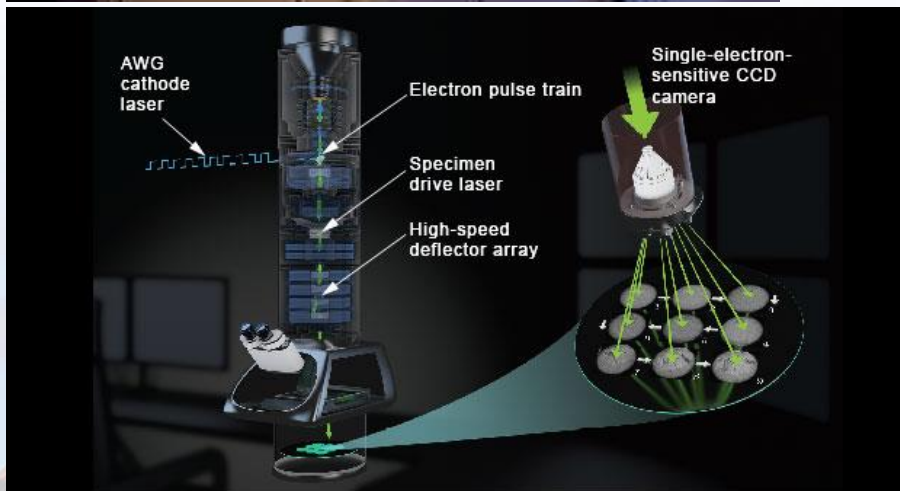


Can I³TEM and DTEM systems be combined?

LLNL DTEM



SNL I³TEM

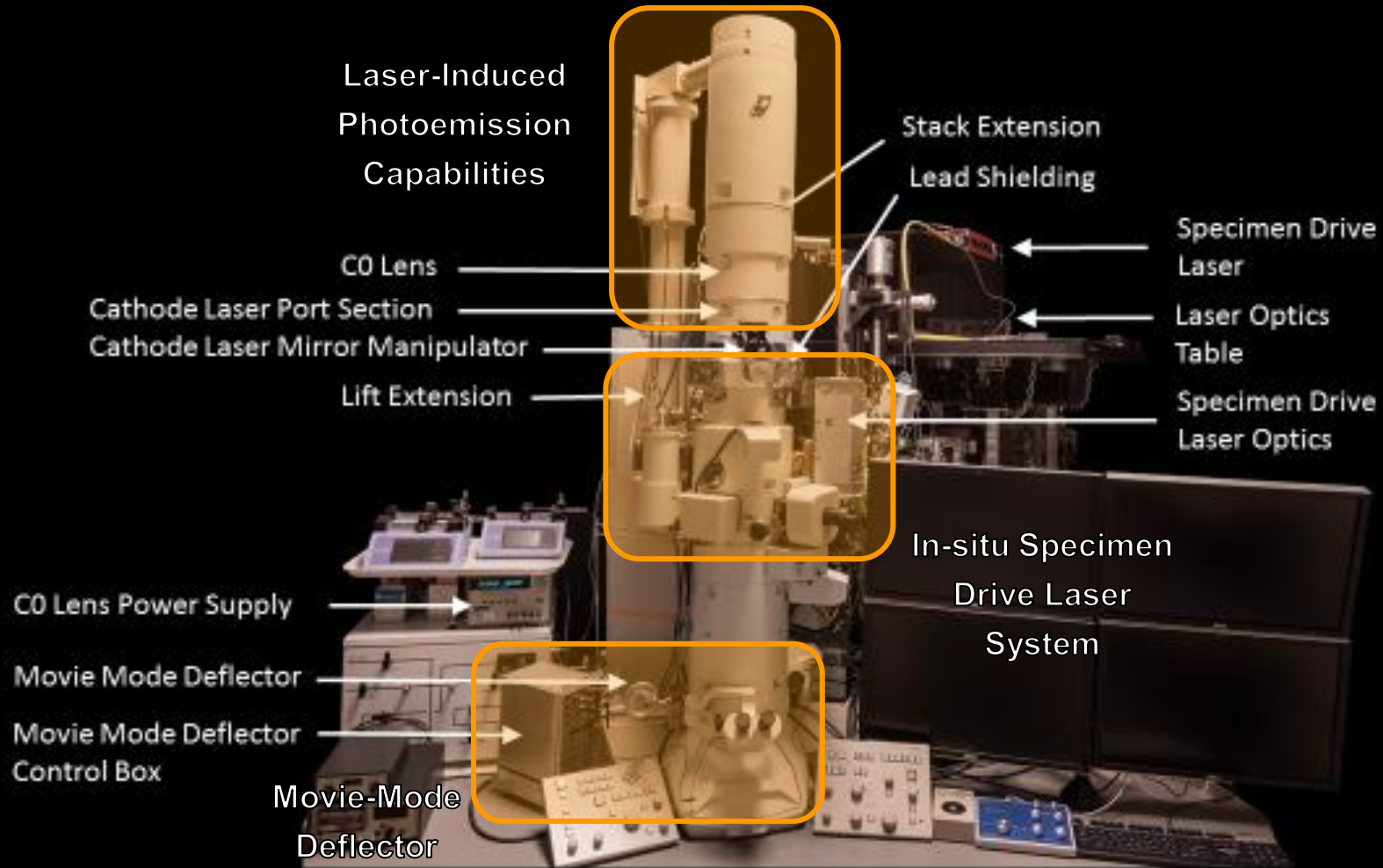


Goal:

Combine the state-of-the-art in microscopy of DTEM and I³TEM to elucidate the response of extreme overlapping environments with adequate spatial and temporal resolution.



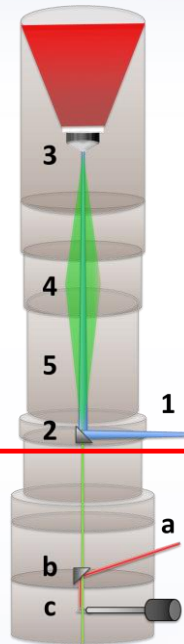
Current Status of Laser Addition and DTEM Conversion



In-situ Specimen Drive Laser System

Specimen Drive Laser

- a. Adjustable power 1064 nm infrared specimen (IR) drive laser
- b. IR laser is reflected directly onto the specimen with metal mirror
- c. Heat specimens in *in situ* holders, which otherwise would not be possible
- Laser capabilities:
 - 2-20 Watts
 - Pulsed or continuous operation
 - 50 μm diameter spot size
 - Positioning mirror, which can be used during laser operation



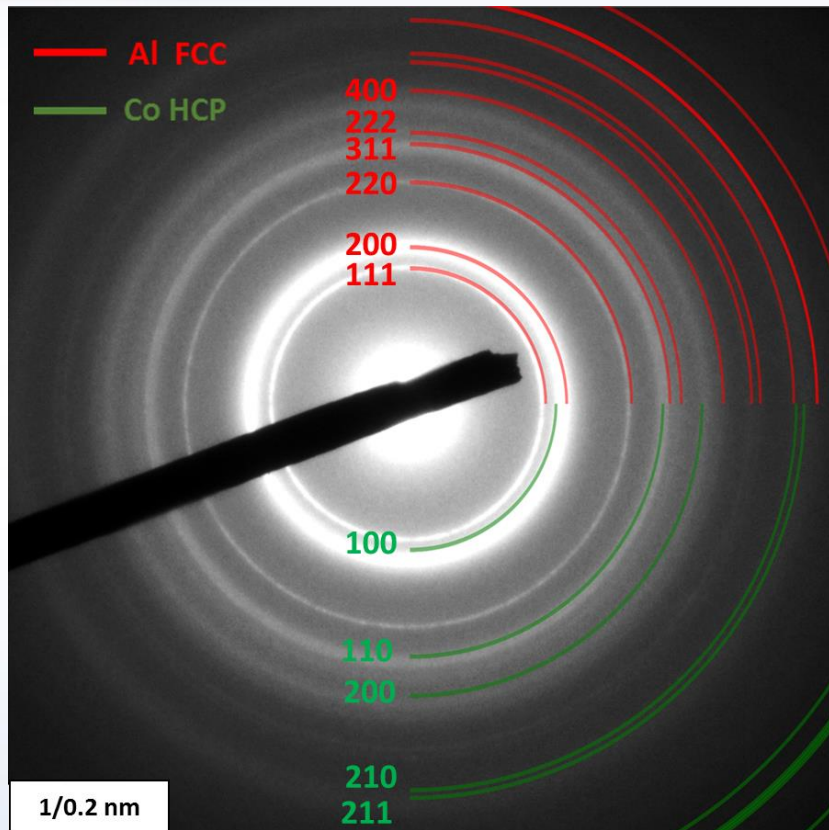
Electron Beam

IR Laser

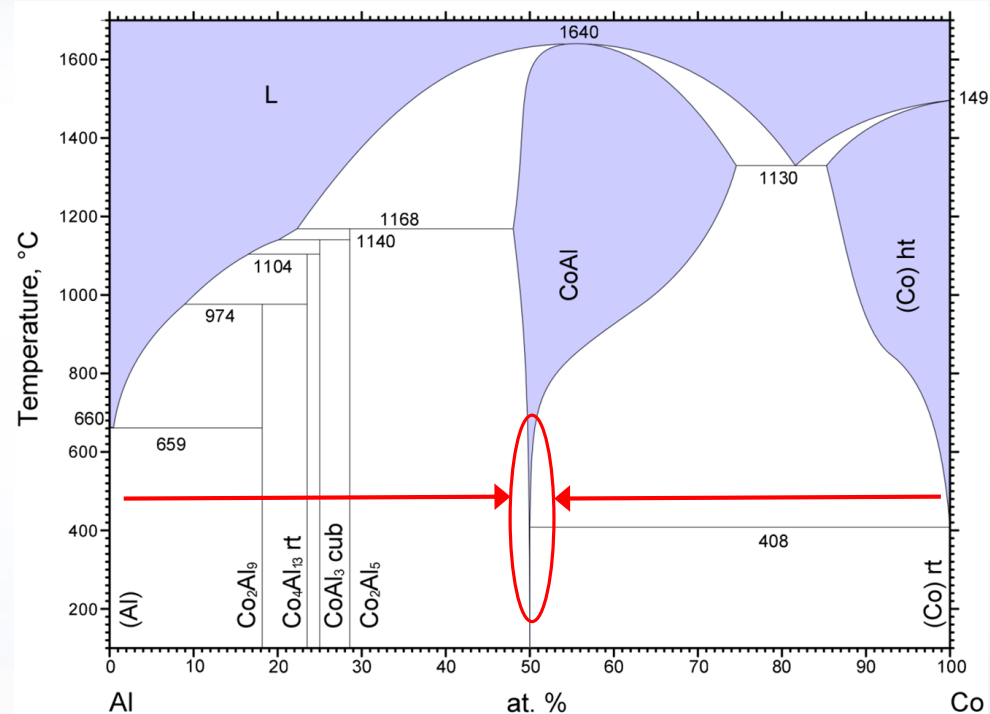
Laser Alignment TEM Holder

- Phosphor screen
- Borescope
- CCD camera
- Precise alignment of the laser to the electron beam

Motivation: Laser, Ion, and Electron Interactions in Multilayer Reactive Foils



Above: Indexed selected area electron diffraction pattern of the two phases in the pre-reacted film



β Phase (50:50)

FCC Structure

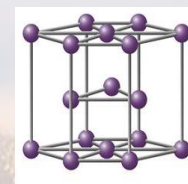
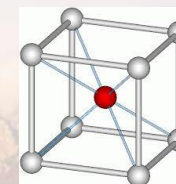
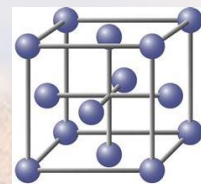
Cubic CsCl Structure

HCP Structure

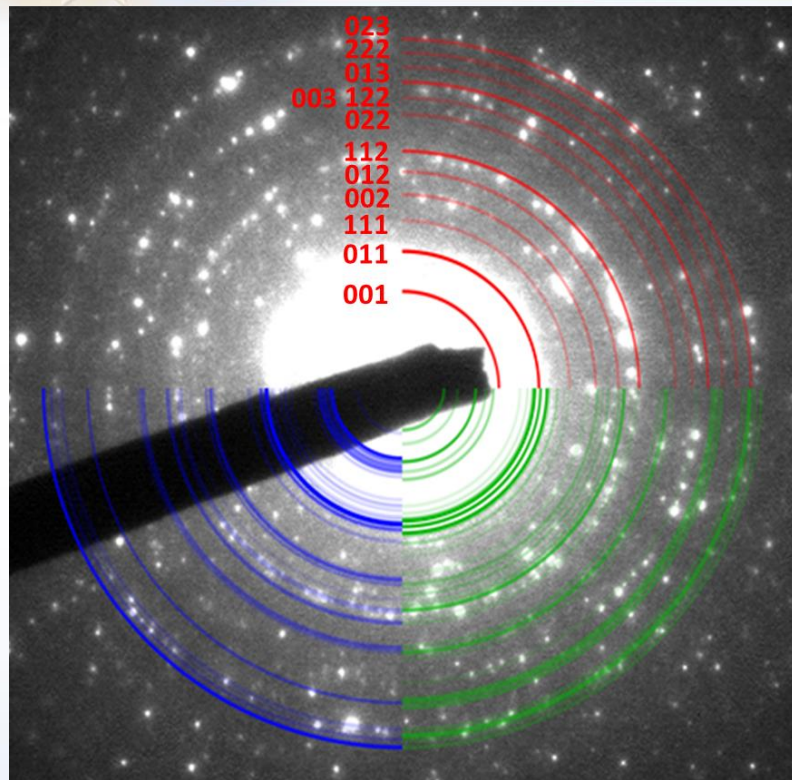
Fm $\bar{3}$ m

Pm $\bar{3}$ m

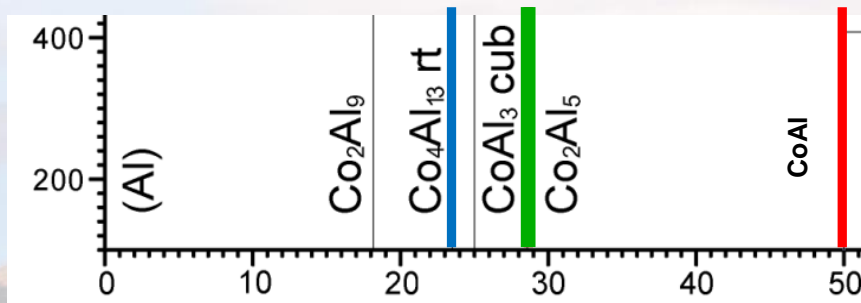
P63/mmc



Motivation: Laser, Ion, and Electron Interactions in Multilayer Reactive Foils



Line compounds in the phase diagram

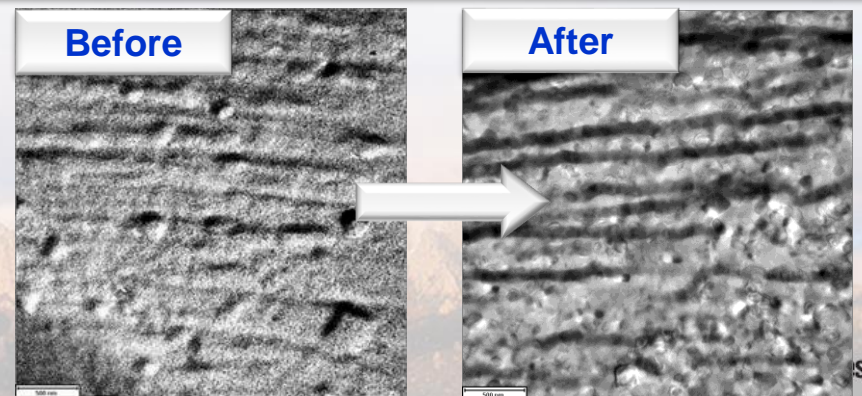


- Equilibrium phase: Cubic β CoAl (line compound)
- Other non-equilibrium phases may form due to local chemical variations
- Three possible line compound phases

• CoAl (β)	$Pm\bar{3}m$	Cubic Structure
• Co ₂ Al ₅	$P63/mmc$	Hexagonal Structure
• Co ₄ Al ₁₃	$Pmn21$	Orthorhombic Structure
- A significant fraction of the intensity in the diffraction pattern is from the β CoAl phase shown in red

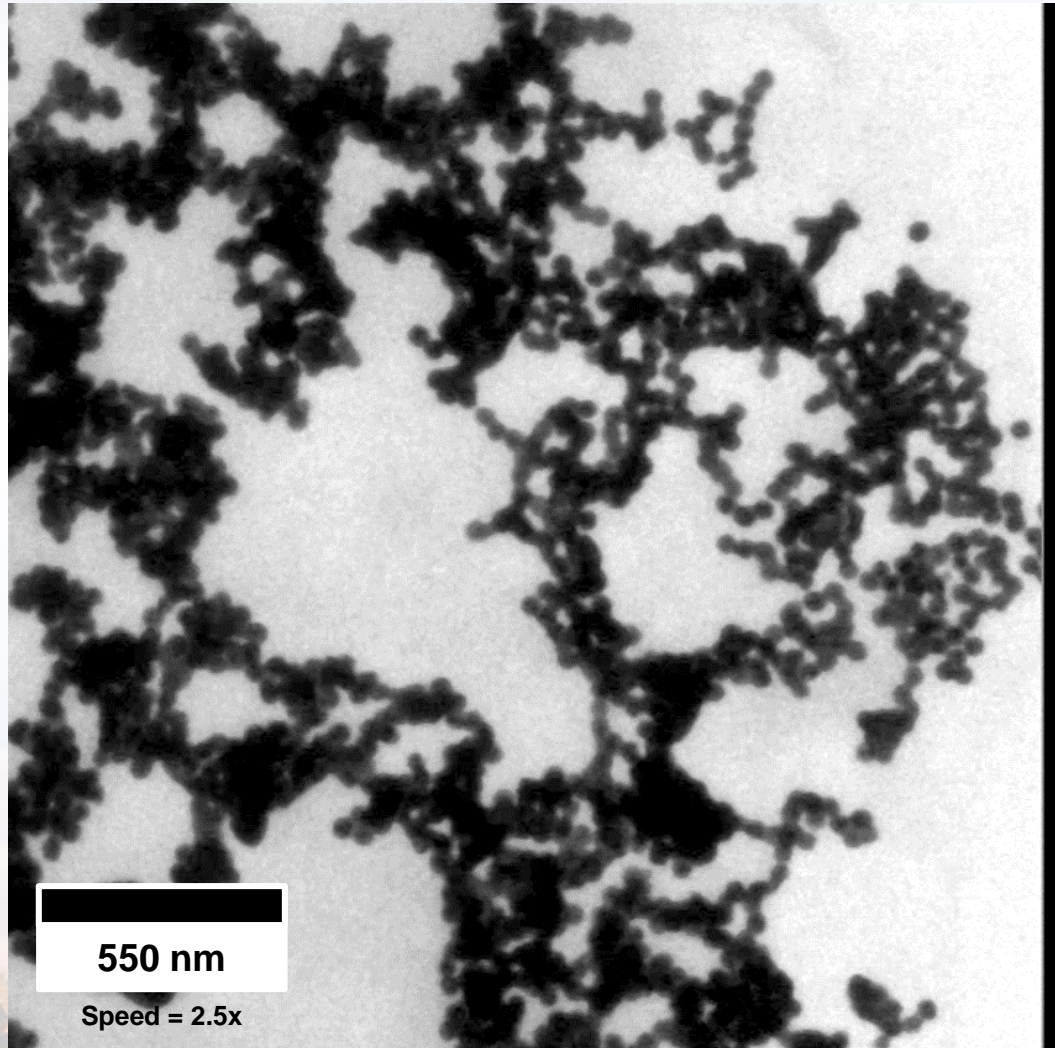
Laser Initiation of MLF has been initiated with a 1064 nm IR laser

The effects of laser, ion, and electron irradiation can all be probed in the same TEM



Motivation: Interaction of NPs During Laser Irradiation

- Observe laser-nanoparticle interactions with sufficient temporal and spatial resolution to see relevant dynamics
- Stabilized video shows behavior of Au nanoparticles during laser irradiation with increasing laser power
- Investigate sintering and consolidation mechanisms with increased temporal resolution
- Possible applications to increase understanding of additive manufacturing systems



A Complex Combination of Sintering, Reactions, and Ablation Occurs

Movie-Mode deflector : μs Resolution with a Standard Camera

fs

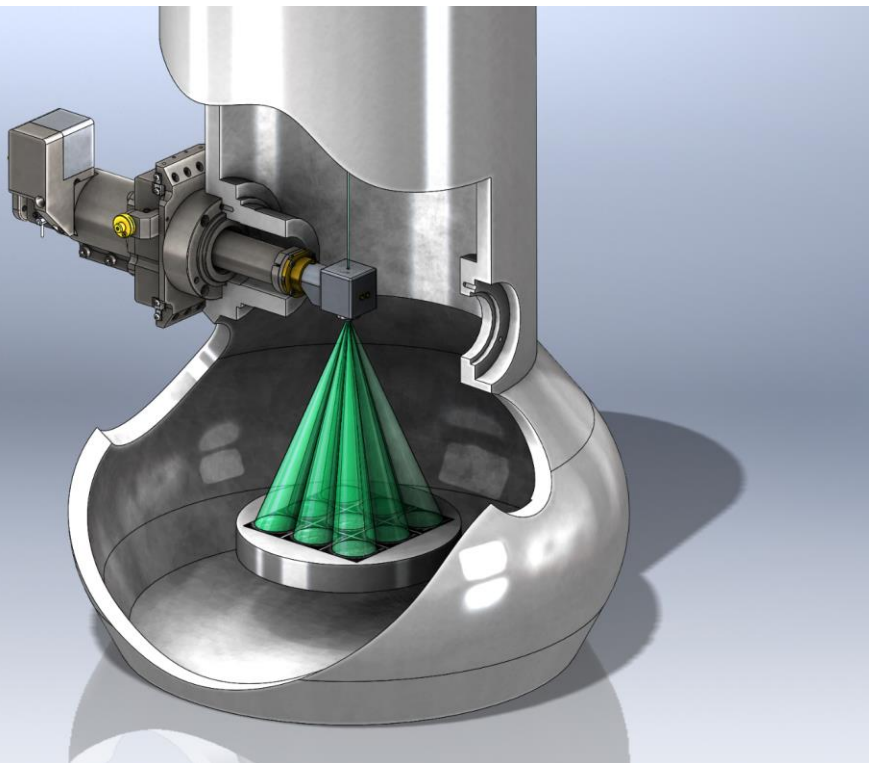
ps

ns

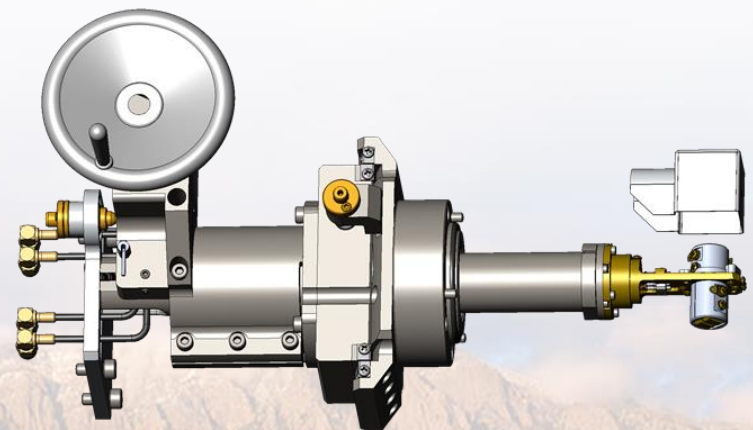
μs

ms

s

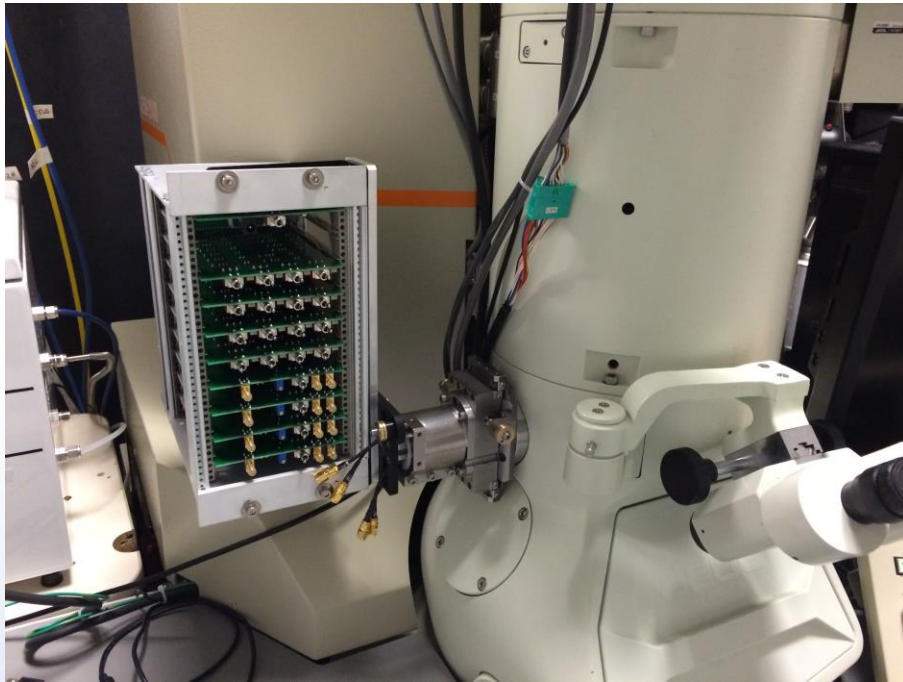


- Electrostatic deflection of electrons
- 4, 9, or 16 images per frame, spread over a large camera
- Any exposure time up to the limits of the camera
 - Ultimate limit is beam current/brightness

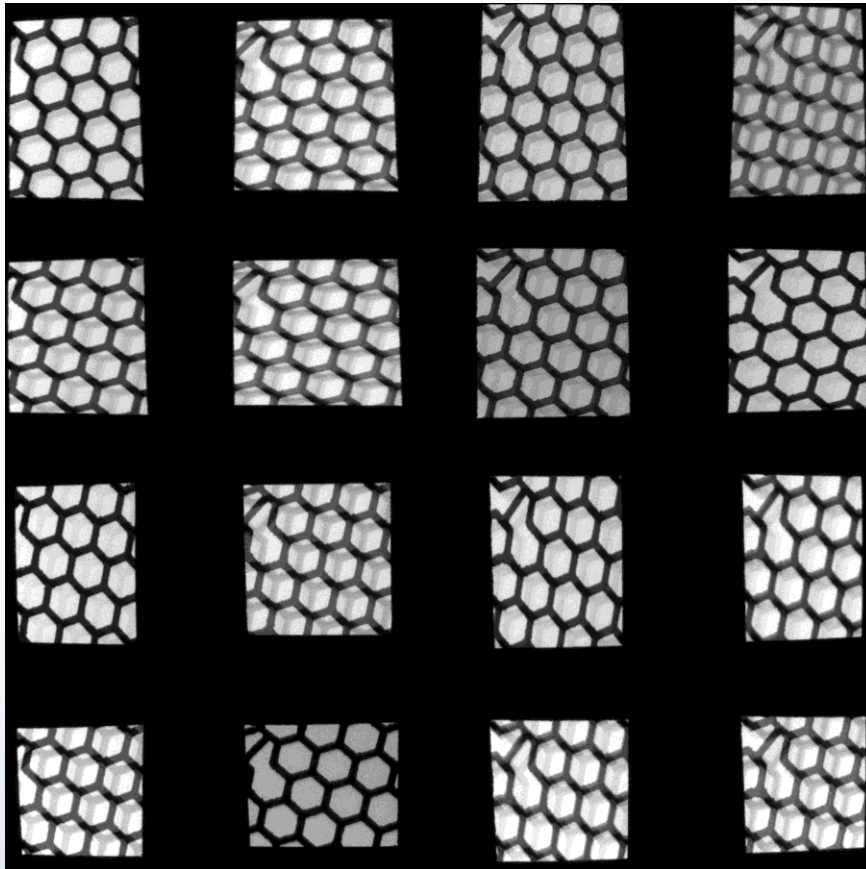


Sandia National Laboratories

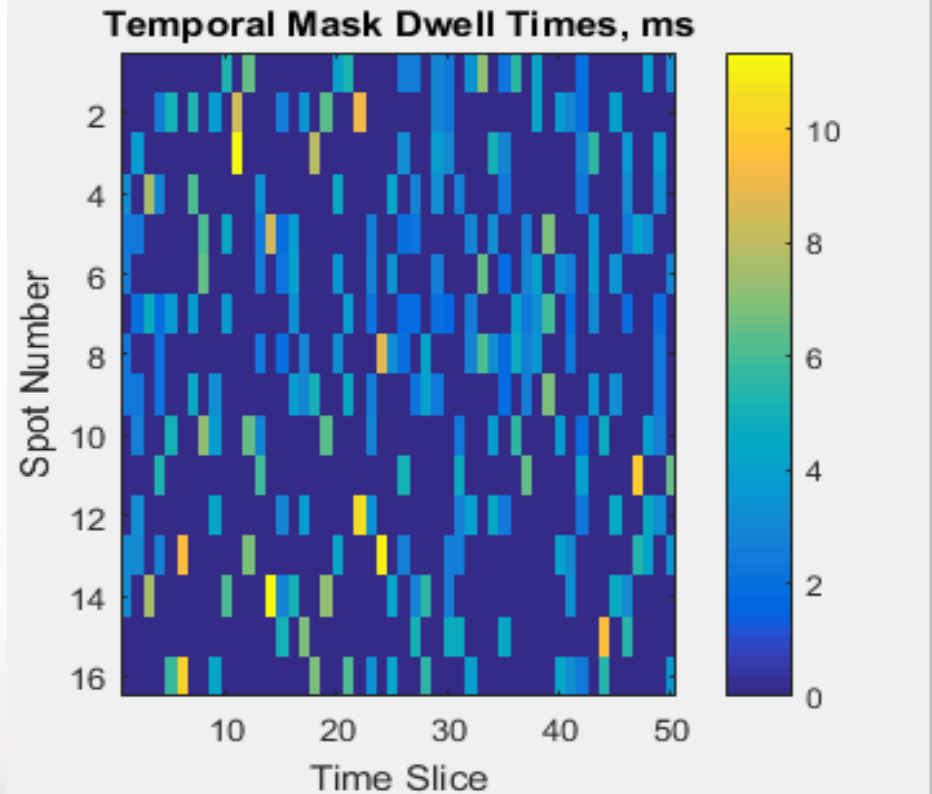
Demonstration of Movie-Mode Deflectors at Sandia



Movie Mode & Temporal Compressive Sensing



Up to 100 exposures can be acquired on a single camera frame giving μs temporal resolution

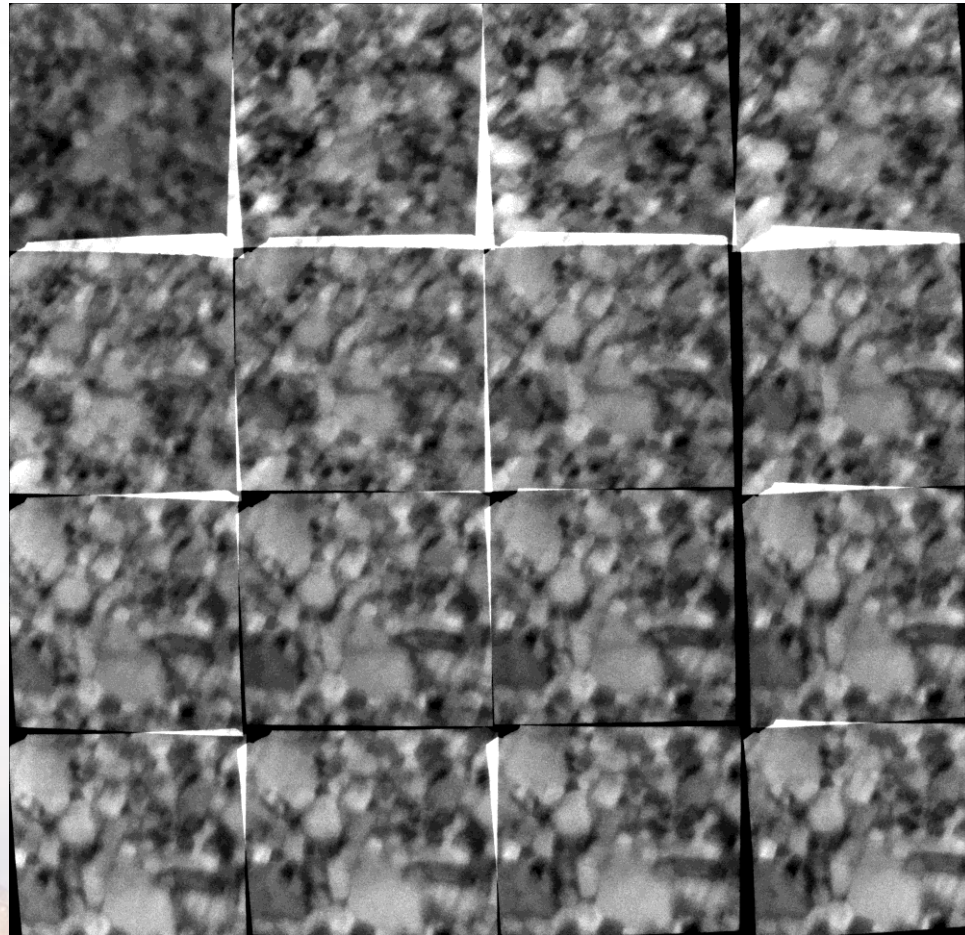
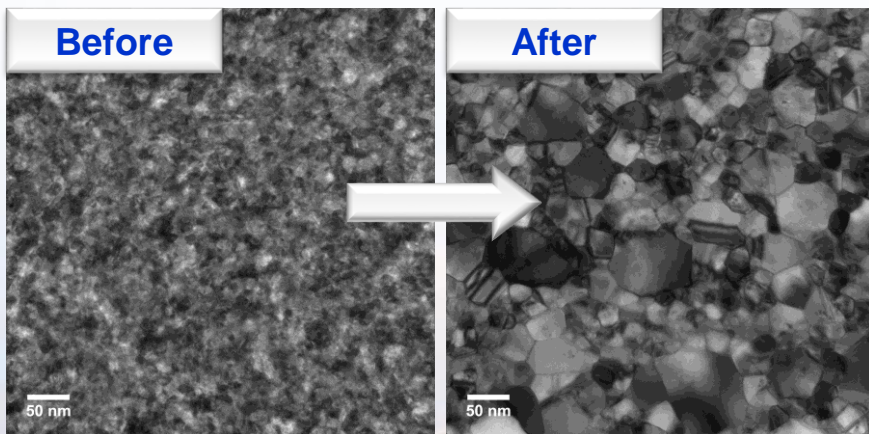


- Electron intensity of a single exposure is randomly distributed to multiple images within a single frame
- Record of random mask used to distribute exposure intensity is later used deconvolute images

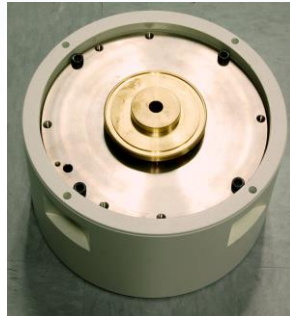
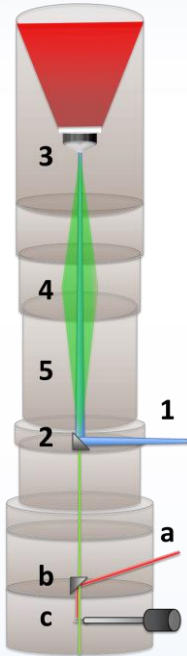
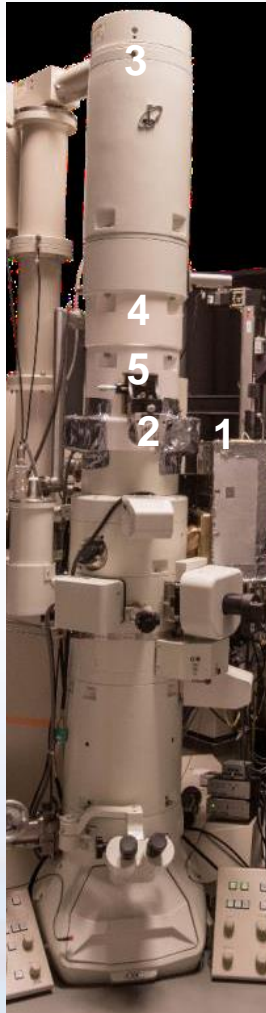
Motivation: In-situ Microstructure Evolution

- In-situ TEM images of IR laser driven grain growth in Pt foil
- Characterize grain boundary and grain evolution
- Rapid heating & cooling controlled by specimen drive laser

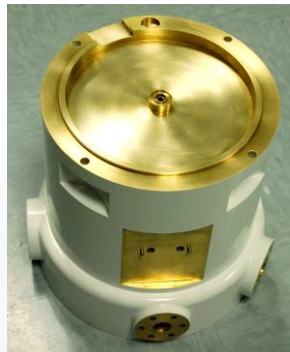
Deflector System: Evolution of Pt microstructure with ~10ms exposures shown on the right



Conversion of a Standard JEOL 2100 TEM to DTEM: Increase Current Density



C_0 Lens



Drift Section



UV Laser

A standard LaB_6 TEM has on average 1 or 2 electrons in the column at a given time!

Laser induced photoemission of electrons can increase nanosecond electron current by 6-8 orders of magnitude

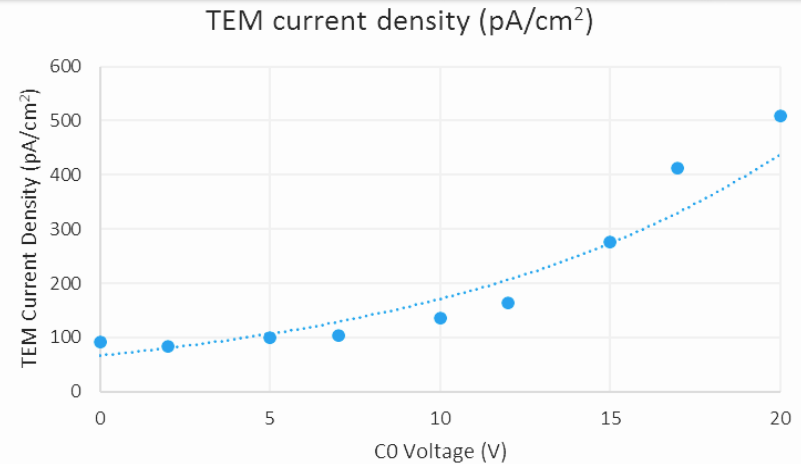
DTEM Development

1. Ultraviolet laser and optics system capable of producing nanosecond pulses
2. Adjustable molybdenum mirror assembly to reflect the UV laser up the column
3. Tantalum cathode disc filament
4. Addition of a C_0 lens and power supply to gather electrons increasing current to the specimen
5. Addition of a drift section to condense electrons from the C_0 lens
6. Lead shielding as needed to ensure safe operation of the instrument

Increased Current Density & added 18" to TEM Column



Addition of C_0 lens and drift section give a 5X increase in current density



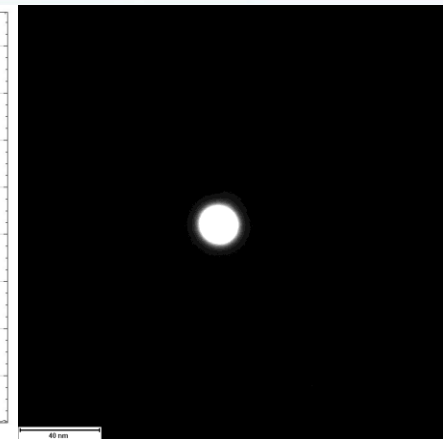
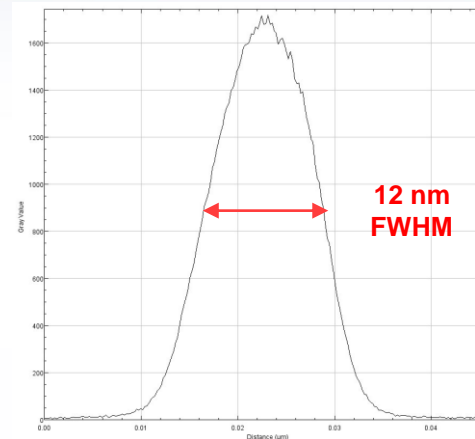
- Disc cathode produces wider distribution of electrons than LaB_6
- Current density can be increased by adding C_0 lens to condense electrons to a smaller probe
- Strength of C_0 lens is controlled by external adjustable power supply
 - Trade off between current density and resolution
- Drift section gives more time for electrons to condense after the C_0 lens. C_0 can be weaker



Tantalum Filament Exchange

■ Changes with C_0 lens setting of 0V

- 50% reduction in electron
 - ♦ LaB_6 ~ 50 pA/cm²
 - ♦ Ta ~ 30 pA/cm²
- Higher beam current at from source
 - ♦ LaB_6 ~ 7 μA
 - ♦ Ta ~ 23 μA
- Increase in minimum spot size for precession
 - ♦ LaB_6 ~ 8 nm FWHM
 - ♦ Ta ~ 12 nm FWHM

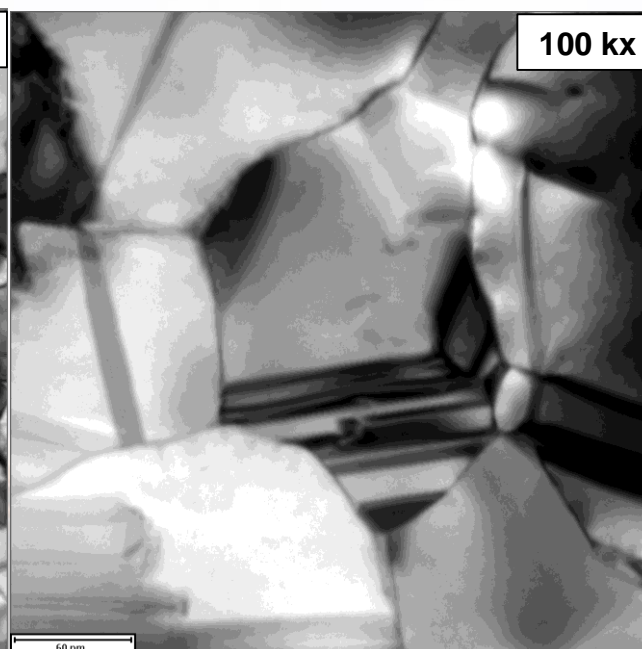
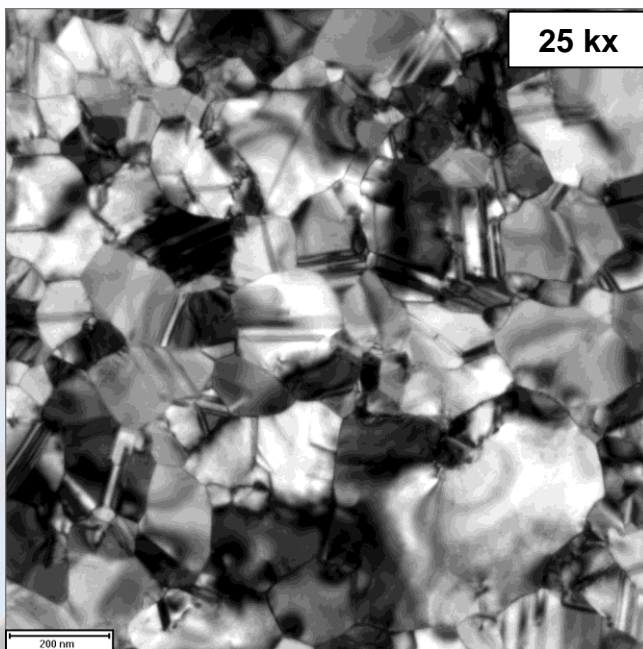


Above:

Smallest achievable spot size for precession with Ta cathode

Left:

Bright field TEM images of nanocrystalline gold taken with Ta filament



Easily switch between DTEM and thermal emission with good resolution in minutes!

Filament exchange in as little as 90 min.



Sandia National Laboratories

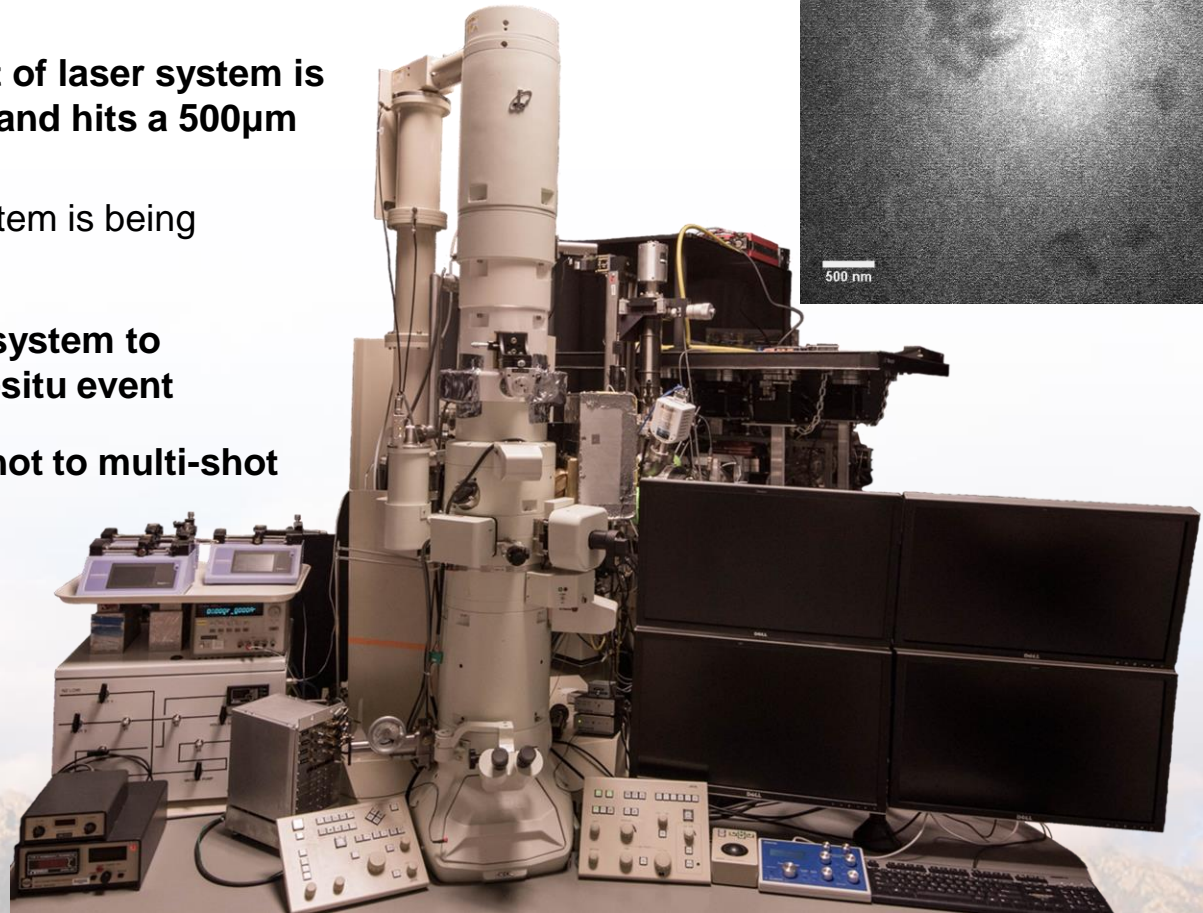
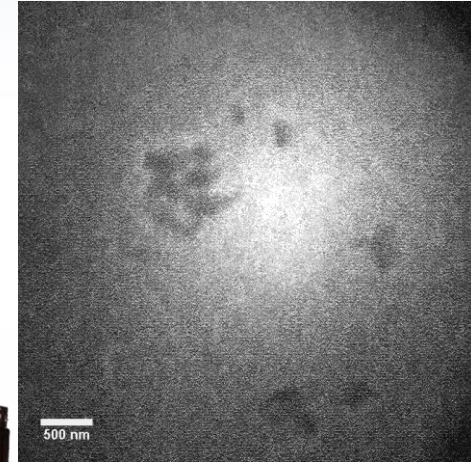
Achieved Laser Induced Photoemission of Electrons

266 nm UV laser induced photoemission has been achieved!

6 ns single-shot DTEM image of P47

Future work

- **Current Impediment:** Alignment of laser system is not trivial. Laser travels meters and hits a 500 μ m disc
 - Next generation alignment system is being developed
- Addition of photodiode timing system to synchronize laser pulse and in-situ event
- Converting laser from single-shot to multi-shot
- Increasing stability of laser
- Laser upgrade



Sandia National Laboratories

Motivation: In-Situ Single Ion Strikes in Si

30 nm



difference
image



- 1.7 MeV Au into single crystal Si
- Single ion strikes can be observed in semiconductors
- Non-symmetric structure in contrast to the spherical approximation

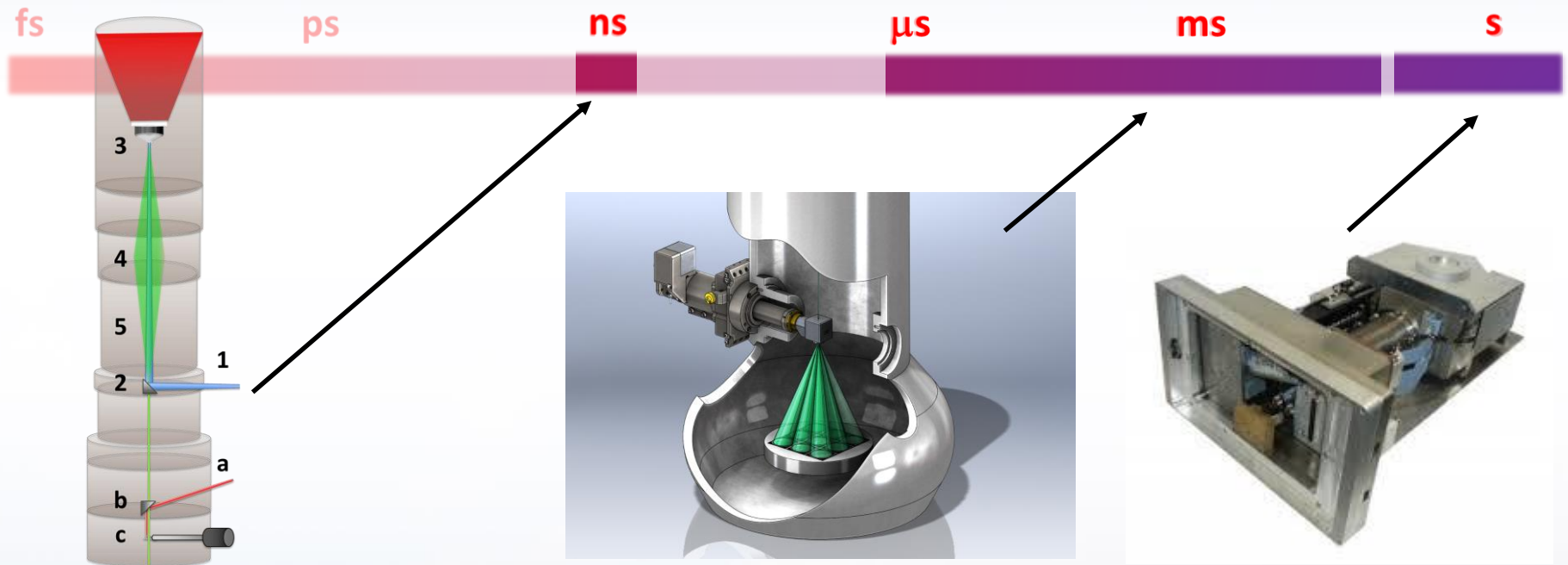
Can we go beyond this to observe:

- Important aspects of structural evolution (ns to hrs.)?
- Evolution in more complex systems (GaAs)?
- Directly correlate it to key model parameters?



Sandia National Laboratories

Increasing Temporal Resolution



■ DTEM

- Laser induced photoemission of electrons is needed to achieve sufficient current density to produce an image
- Provides nanosecond imaging of irreversible process

■ Deflector System

- Multiple images acquired on single frame
- Microsecond imaging possible
- Virtually no missing data (nanosecond gaps)

■ Standard 1K TVIPS camera

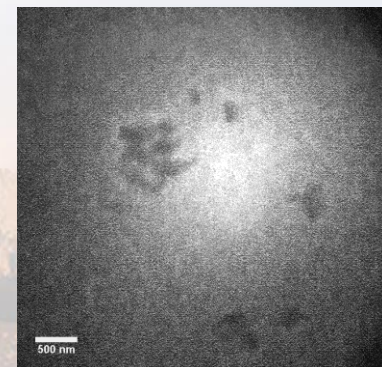
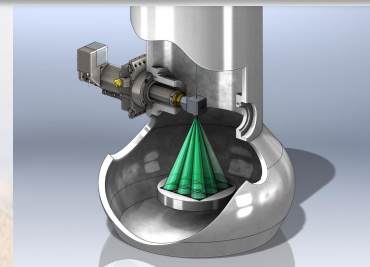
- Due to camera read out rate few images can be acquired
- 10-20fps maximum
- Missing data during camera readout





Summary

- Fundamental TEM modifications for DTEM, movie mode, and compressive sensing have been completed.
- Maintained functionality of the TEM using LaB_6 thermal emission with minimal impact
- Ability to switch between DTEM and Ta cathode thermal emission in minutes with good spatial resolution
- Possible to switch between LaB_6 and DTEM in just a few hours
- Movie Mode/Compressive sensing can achieve microsecond temporal resolution
- Laser induced photoemission of electrons has been achieved with in 6 ns temporal resolution
- DTEM and movie mode functionality on the I^3TEM combined with the wide range of available in-situ holders will provide the unique capability to observe materials and ion irradiation processes in-situ with nano and microsecond temporal resolution



This work was partially funded by the Division of Materials Science and Engineering, Office of Basic Energy Sciences, U.S. Department of Energy. Sandia National Laboratories is a multi-mission laboratory managed and operated by National Technology and Engineering Solutions of Sandia, LLC., a wholly owned subsidiary of Honeywell International, Inc., for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-NA-0003525.